

## 8-Kbit serial I<sup>2</sup>C bus EEPROM



### Features

- Compatible with following I<sup>2</sup>C bus modes:
  - 400 kHz
  - 100 kHz
- Memory array:
  - 8 Kbit (1 Kbyte) of EEPROM
  - Page size: 16 byte
- Single supply voltage:
  - M24C08-W: 2.5 V to 5.5 V
  - M24C08-R: 1.8 V to 5.5 V
  - M24C08-F:
    - 1.7 V to 5.5 V
    - 1.6 V to 5.5 V (under temperature constraint)
- Write:
  - Byte write within 5 ms
  - Page write within 5 ms
- Operating temperature range:
  - from -40 °C up to +85 °C
- Random and sequential read modes
- Write protect of the whole memory array
- Enhanced ESD/latch-Up protection
- More than 4 million write cycles
- More than 200-years data retention

### Packages

Packages RoHS-compliant and Halogen-free

- SO8N (ECOPACK2)
- TSSOP8 (ECOPACK2)
- UFDFPN8 (ECOPACK2)
- UFDFPN5 (ECOPACK2)
- WLCSP (ECOPACK2)

| Product status link      |
|--------------------------|
| <a href="#">M24C08-W</a> |
| <a href="#">M24C08-R</a> |
| <a href="#">M24C08-F</a> |

## 1 Description

The M24C08 is an 8-Kbit I<sup>2</sup>C-compatible EEPROM (electrically erasable programmable memory) organized as 1 K × 8 bits.

The M24C08-W can be accessed with a supply voltage from 2.5 V to 5.5 V, the M24C08-R can be accessed with a supply voltage from 1.8 V to 5.5 V, and the M24C08-F can be accessed either with a supply voltage from 1.7 V to 5.5 V (over the full temperature range) or with an extended supply voltage from 1.6 V to 5.5 V under some restricted conditions.

**Figure 1. Logic diagram**

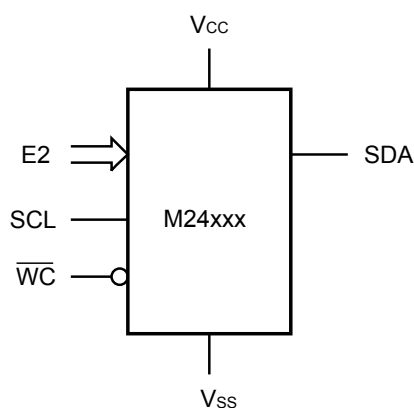


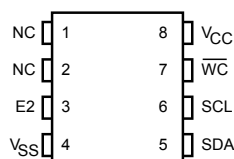
**Table 1. Signal names**

| Signal name       | Function       | Direction |
|-------------------|----------------|-----------|
| E2 <sup>(1)</sup> | Chip enable    | Input     |
| SDA               | Serial data    | I/O       |
| SCL               | Serial clock   | Input     |
| WC <sup>(2)</sup> | Write control  | Input     |
| VCC               | Supply voltage | -         |
| VSS               | Ground         | -         |

1. Signal not connected in the DFN5 and WLCSP packages.

2. Signal not connected in the WLCSP package

Figure 2. 8-pin package connections, top view



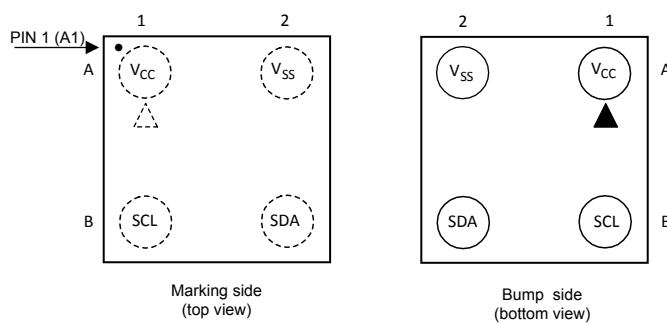
1. NC: not connected.
2. See [Section 9 Package information](#) for package dimensions, and how to identify pin 1

Figure 3. UDFPN5 (DFN5) package connections



1. Inputs E2 is not connected. Refer to [Section 4.5 Device addressing](#) for further explanations.

Figure 4. WLCSP connections (top view, marking side, with balls on the underside)



1. The E2 and  $\overline{WC}$  inputs are not connected to a ball.  $\overline{WC}$  input is therefore decoded as "0" and the device remains always accessible in write mode (see also [Section 2.4 Write control \(WC\)](#)).

Table 2. WLCSP signals vs. bump position

| Position | A               | B   |
|----------|-----------------|-----|
| 1        | V <sub>CC</sub> | SCL |
| 2        | V <sub>SS</sub> | SDA |

## 2 Signal description

### 2.1 Serial clock (SCL)

The signal applied on the SCL input is used to strobe the data available on SDA(in) and to output the data on SDA(out).

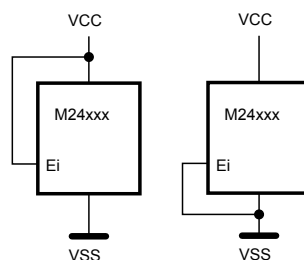
### 2.2 Serial data (SDA)

SDA is an input/output used to transfer data in or data out of the device. SDA(out) is an open drain output that may be wired-AND with other open drain or open collector signals on the bus. A pull-up resistor must be connected from serial data (SDA) to  $V_{CC}$  (Figure 13 indicates how to calculate the value of the pull-up resistor).

### 2.3 Chip enable (E2)

This input signal is used to set the value that is to be looked for on the bit b3 of the device select code. This input must be tied to  $V_{CC}$  or  $V_{SS}$ , to establish the device select code as shown in Figure 4. When not connected (left floating), this input is read as low (0).

Figure 5. Chip enable inputs connection



For the UDFPN5 package, the E2 input is not connected.

### 2.4 Write control ( $\overline{WC}$ )

This input signal is useful for protecting the entire contents of the memory from inadvertent write operations. Write operations are disabled to the entire memory array when write control ( $\overline{WC}$ ) is driven high. Write operations are enabled when write control ( $\overline{WC}$ ) is either driven low or left floating.

When write control ( $\overline{WC}$ ) is driven high, device select and address bytes are acknowledged, data bytes are not acknowledged.

### 2.5 $V_{SS}$ (ground)

$V_{SS}$  is the reference for all signals, including the  $V_{CC}$  supply voltage.

### 2.6 Supply voltage ( $V_{CC}$ )

#### 2.6.1 Operating supply voltage ( $V_{CC}$ )

Prior to selecting the memory and issuing instructions to it, a valid and stable  $V_{CC}$  voltage within the specified [ $V_{CC}(\min)$ ,  $V_{CC}(\max)$ ] range must be applied (see Operating conditions in Section 8 DC and AC parameters). In order to secure a stable DC supply voltage, it is recommended to decouple the  $V_{CC}$  line with a suitable capacitor (usually of the order of 10 nF to 100 nF) close to the  $V_{CC}/V_{SS}$  package pins.

This voltage must remain stable and valid until the end of the transmission of the instruction and, for a write instruction, until the completion of the internal write cycle ( $t_W$ ).

### 2.6.2 Power-up conditions

The  $V_{CC}$  voltage has to rise continuously from 0 V up to the minimum  $V_{CC}$  operating voltage (see Operating conditions in [Section 8 DC and AC parameters](#)).

### 2.6.3 Device reset

In order to prevent inadvertent write operations during power-up, a power-on-reset (POR) circuit is included. At power-up, the device does not respond to any instruction until  $V_{CC}$  has reached the internal reset threshold voltage. This threshold is lower than the minimum  $V_{CC}$  operating voltage (see Operating conditions in [Section 8 DC and AC parameters](#)). When  $V_{CC}$  passes over the POR threshold, the device is reset and enters the standby power mode; however, the device must not be accessed until  $V_{CC}$  reaches a valid and stable DC voltage within the specified [ $V_{CC}(\text{min})$ ,  $V_{CC}(\text{max})$ ] range (see Operating conditions in [Section 8 DC and AC parameters](#)).

In a similar way, during power-down (continuous decrease in  $V_{CC}$ ), the device must not be accessed when  $V_{CC}$  drops below  $V_{CC}(\text{min})$ . When  $V_{CC}$  drops below the power-on-reset threshold voltage, the device stops responding to any instruction sent to it.

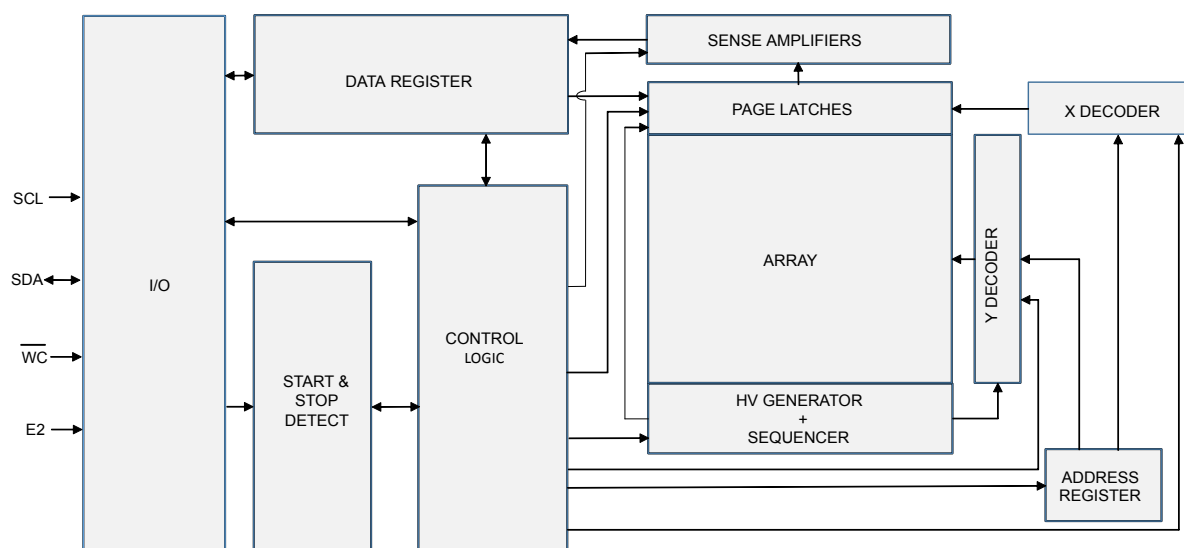
### 2.6.4 Power-down conditions

During power-down (continuous decrease in  $V_{CC}$ ), the device must be in the standby power mode (mode reached after decoding a stop condition, assuming that there is no internal write cycle in progress).

### 3 Block diagram

The block diagram of the device is described below.

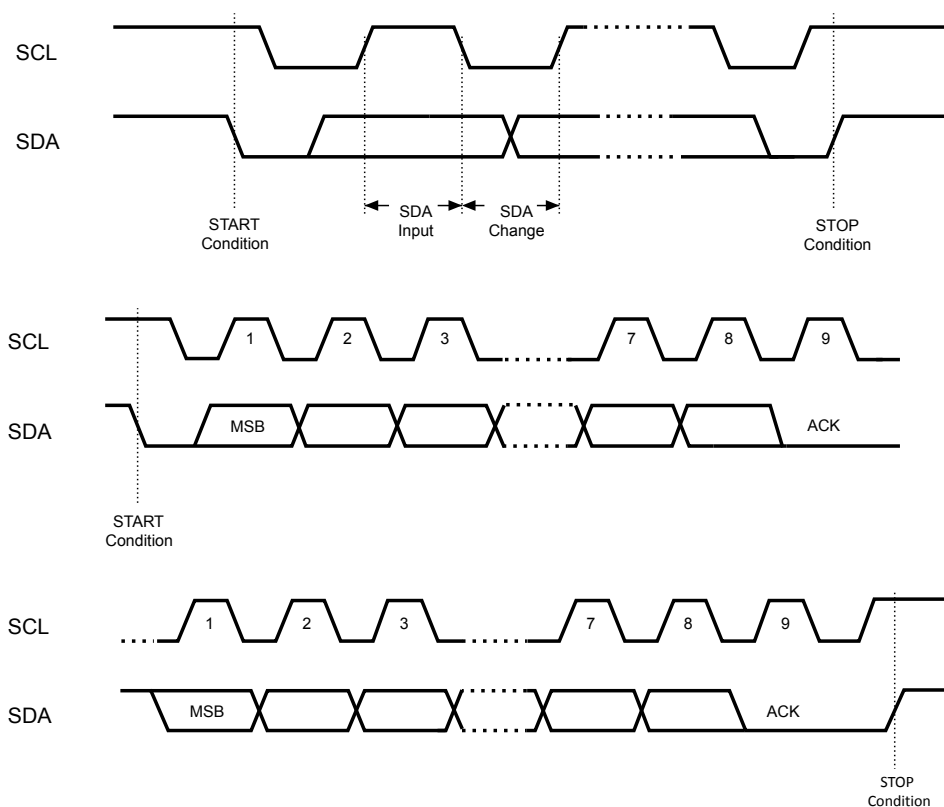
Figure 6. Block diagram



## 4 Device operation

The device supports the I<sup>2</sup>C protocol. This is summarized in Figure 7. Any device that sends data on to the bus is defined to be a transmitter, and any device that reads the data to be a receiver. The device that controls the data transfer is known as the bus master, and the other as the slave device. A data transfer can only be initiated by the bus master, which also provides the serial clock for synchronization. The device is always a slave in all communications.

Figure 7. I<sup>2</sup>C bus protocol



## 4.1 Start condition

Start is identified by a falling edge of serial data (SDA) while serial clock (SCL) is stable in the high state. A start condition must precede any data transfer instruction. The device continuously monitors (except during a write cycle) serial data (SDA) and serial clock (SCL) for a start condition.

## 4.2 Stop condition

Stop is identified by a rising edge of serial data (SDA) while serial clock (SCL) is stable in the high state. A stop condition terminates communication between the device and the bus master. A read instruction that is followed by NoAck can be followed by a stop condition to force the device into the standby mode.

A stop condition at the end of a write instruction triggers the internal write cycle.

## 4.3 Data input

During data input, the device samples serial data (SDA) on the rising edge of serial clock (SCL). For correct device operation, serial data (SDA) must be stable during the rising edge of serial clock (SCL), and the serial data (SDA) signal must change only when serial clock (SCL) is driven low.

## 4.4 Acknowledge bit (ACK)

The acknowledge bit is used to indicate a successful byte transfer. The bus transmitter, whether it be bus master or slave device, releases serial data (SDA) after sending eight bits of data. During the 9<sup>th</sup> clock pulse period, the receiver pulls serial data (SDA) low to acknowledge the receipt of the eight data bits.

## 4.5 Device addressing

To start communication between the bus master and the slave device, the bus master must initiate a Start condition. Following this, the bus master sends the device select code, shown in Table 3 (most significant bit first).

*Note:* When using the DFN5 and WLCSP package:

- The E2 and WC pins are not accessible.
- To properly communicate with the device, the E2 bit must always be set to logic 0 for any operation. See Table 3.
- No other I<sup>2</sup>C device using address 1010 xxxx (x = don't care) can be connected to the same bus.

**Table 3. Device select code**

| Package              | Device type identifier <sup>(1)</sup> |    |    |    | Chip Enable address |    |    | R $\overline{W}$ |
|----------------------|---------------------------------------|----|----|----|---------------------|----|----|------------------|
|                      | b7                                    | b6 | b5 | b4 | b3                  | b2 | b1 | b0               |
| TSSOP8, SO8N, UDFPN8 | 1                                     | 0  | 1  | 0  | E2                  | A9 | A8 | R $\overline{W}$ |
| DFN5, WLCSP          | 1                                     | 0  | 1  | 0  | 0                   | A9 | A8 | R $\overline{W}$ |

1. The MSB, b7, is sent first.

The 8<sup>th</sup> bit is the read/write bit (R $\overline{W}$ ). This bit is set to 1 for read and 0 for write operations.

If a match occurs on the device select code, the corresponding device gives an acknowledgement on serial data (SDA) during the 9<sup>th</sup> bit time. If the device does not match the device select code, it deselects itself from the bus, and goes into standby mode.

## 5 Instructions

### 5.1 Write operations

Following a start condition the bus master sends a device select code with the  $R/\overline{W}$  bit ( $R\overline{W}$ ) reset to 0. The device acknowledges this, as shown in Figure 8, and waits for the address byte. The device responds to each address byte with an acknowledge bit, and then waits for the data byte.

**Table 4. Address byte**

| A7 | A6 | A5 | A4 | A3 | A2 | A1 | A0 |
|----|----|----|----|----|----|----|----|
|----|----|----|----|----|----|----|----|

When the bus master generates a stop condition immediately after a data byte Ack bit (in the “10<sup>th</sup> bit” time slot), either at the end of a byte write or a page write, the internal write cycle  $t_W$  is triggered. A stop condition at any other time slot does not trigger the internal write cycle.

After the stop condition and the successful completion of an internal write cycle ( $t_W$ ), the device internal address counter is automatically incremented to point to the next byte after the last modified byte.

During the internal write cycle, serial data (SDA) is disabled internally, and the device does not respond to any requests.

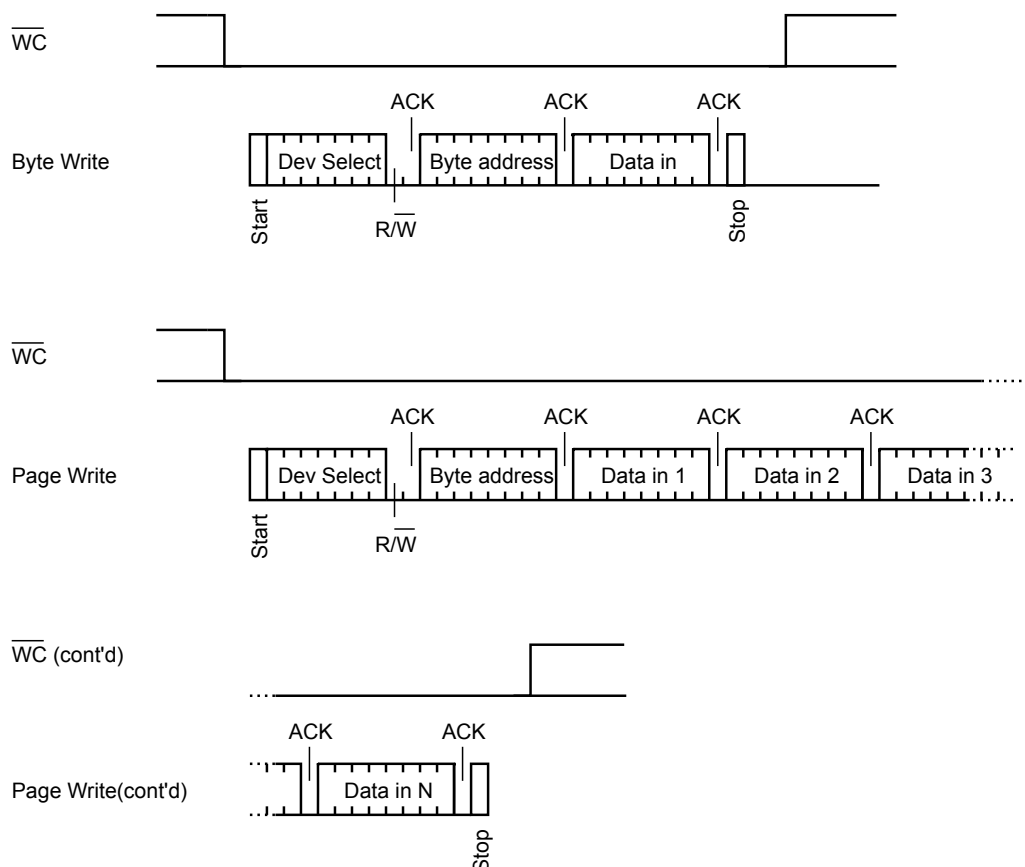
If the write control input ( $\overline{WC}$ ) is driven high, the write instruction is not executed and the accompanying data bytes are *not* acknowledged, as shown in Figure 9.

### 5.1.1

#### Byte write

After the device select code and the address byte, the bus master sends one data byte. If the addressed location is write-protected, by write control ( $\overline{WC}$ ) being driven high, the device replies with NoAck, and the location is not modified. If, instead, the addressed location is not write-protected, the device replies with Ack. The bus master terminates the transfer by generating a stop condition, as shown in Figure 8.

**Figure 8. Write mode sequences with  $\overline{WC} = 0$  (data write enabled)**



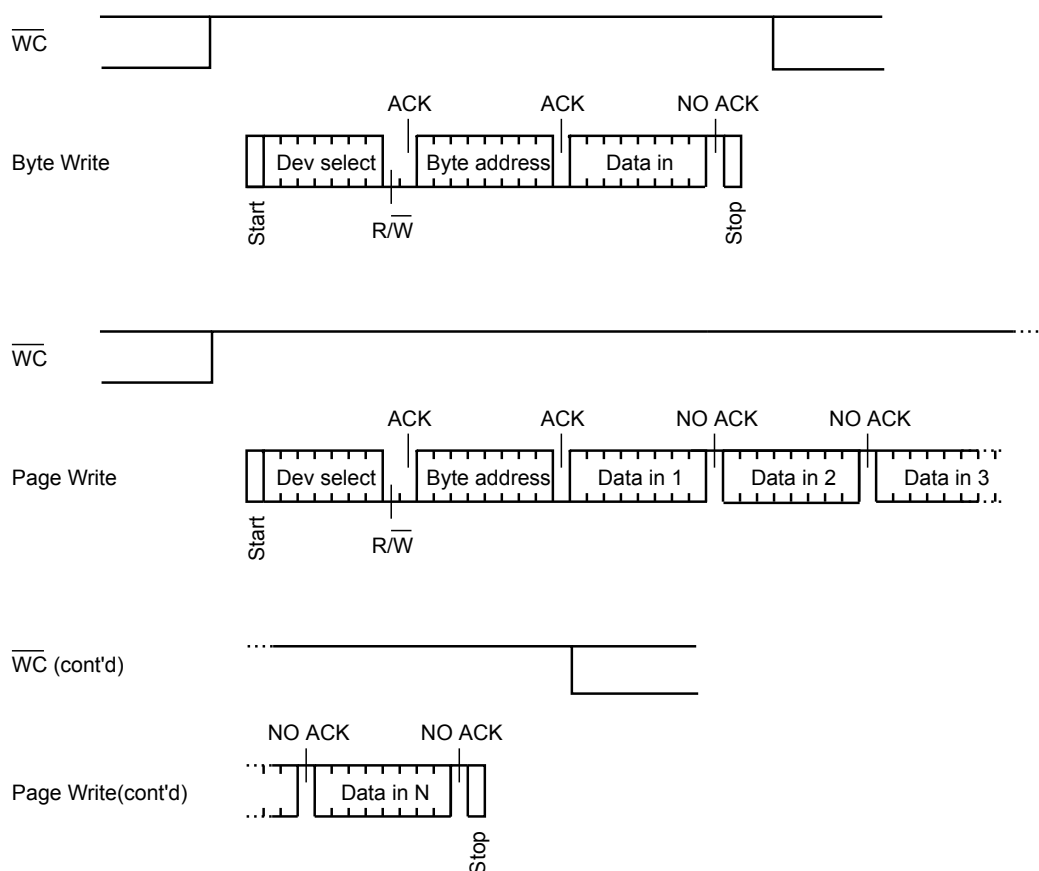
### 5.1.2 Page write

The page write mode allows up to 16 byte to be written in a single write cycle, provided that they are all located in the same page in the memory: that is, the most significant memory address bits, A9/A4, are the same. If more bytes are sent than fit up to the end of the page, a “roll-over” occurs, i.e. the bytes exceeding the page end are written on the same page, from location 0.

The bus master sends from 1 to 16 byte of data, each of which is acknowledged by the device if write control ( $\overline{WC}$ ) is low. If write control ( $\overline{WC}$ ) is high, the contents of the addressed memory location are not modified, and each data byte is followed by a NoAck, as shown in Figure 9. After each transferred byte, the internal page address counter is incremented.

The transfer is terminated by the bus master generating a stop condition.

Figure 9. Write mode sequences with  $\overline{WC} = 1$  (data write inhibited)



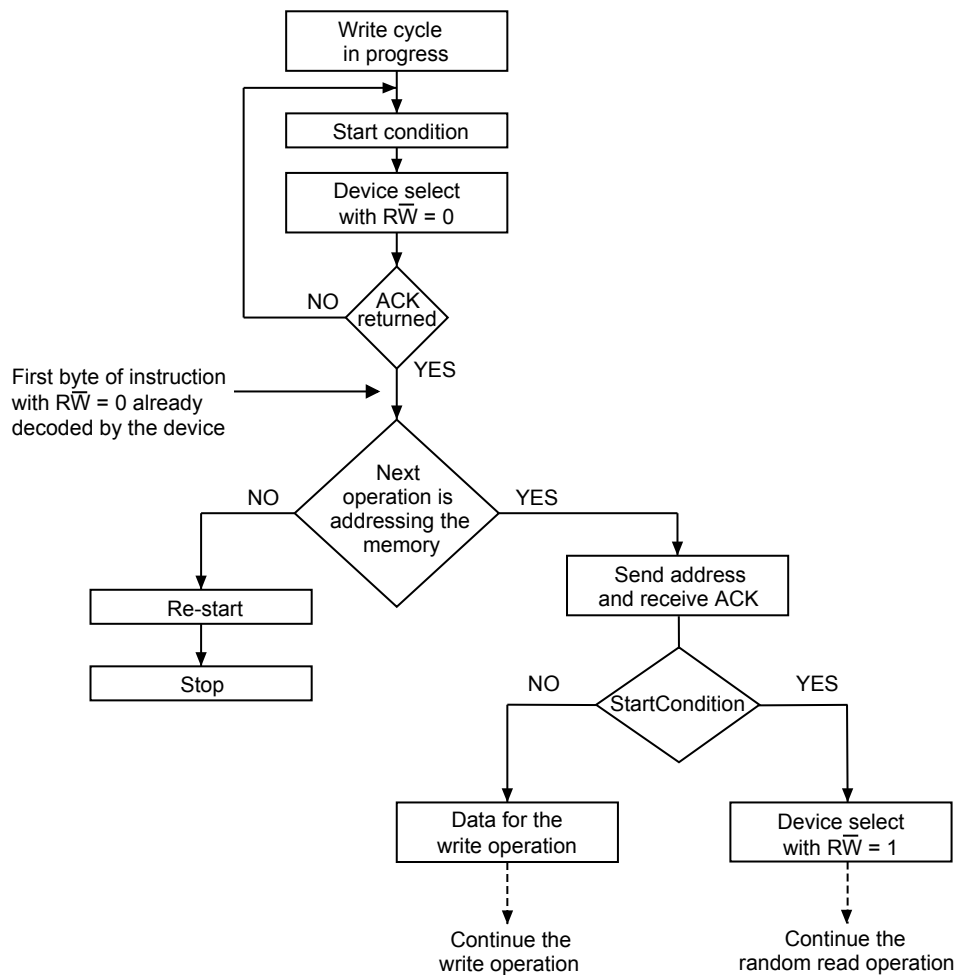
### 5.1.3 Minimizing write delays by polling on ACK

The maximum write time ( $t_w$ ) is shown in [Section 8 DC and AC parameters](#), but the typical time is shorter. To make use of this, a polling sequence can be used by the bus master.

The sequence, as shown in [Figure 10](#), is:

- Initial condition: a write cycle is in progress.
- Step 1: the bus master issues a Start condition followed by a device select code (the first byte of the new instruction).
- Step 2: if the device is busy with the internal write cycle, no Ack is returned and the bus master goes back to step 1. If the device has terminated the internal write cycle, it responds with an Ack, indicating that the device is ready to receive the second part of the instruction (the first byte of this instruction having been sent during Step 1).

**Figure 10. Write cycle polling flowchart using ACK**



1. The seven most significant bits of the device select code of a random read (bottom right box in the [Figure 10](#)) must be identical to the seven most significant bits of the device select code of the write (polling instruction in the [Figure 10](#)).

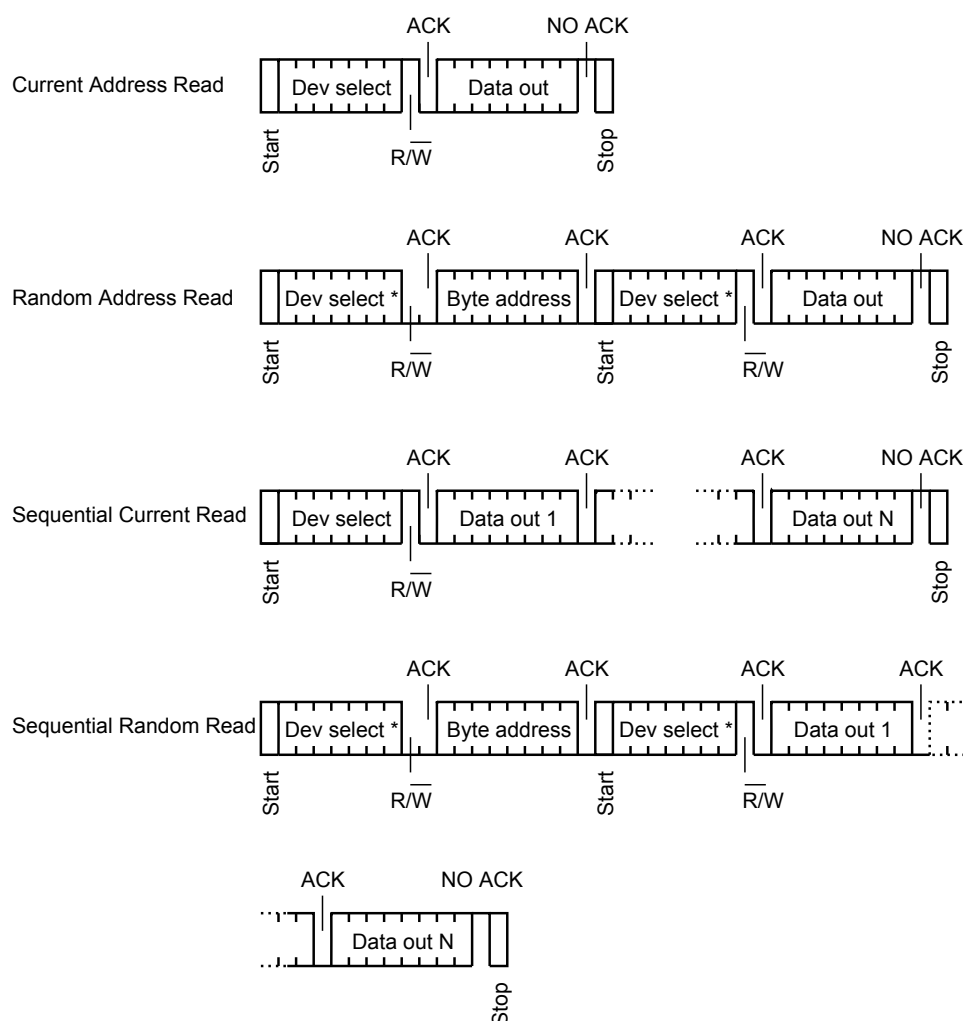
## 5.2 Read operations

Read operations are performed independently of the state of the write control ( $\overline{WC}$ ) signal.

After the successful completion of a read operation, the device internal address counter is incremented by one, to point to the next byte address.

For the read instructions, after each byte read (data out), the device waits for an acknowledgement (data in) during the 9<sup>th</sup> bit time. If the bus master does not acknowledge during this 9<sup>th</sup> time, the device terminates the data transfer and switches to its standby mode after a stop condition.

Figure 11. Read mode sequences



**Note:** The seven most significant bits of the first device select code of a random read must be identical to the seven most significant bits of the device select code of the write.

### 5.2.1 Random address read

A dummy write is first performed to load the address into this address counter (as shown in Figure 11) but without sending a stop condition. Then, the bus master sends another start condition, and repeats the device select code, with the RW bit set to 1. The device acknowledges this, and outputs the contents of the addressed byte. The bus master must not acknowledge the byte, and terminates the transfer with a stop condition.

### 5.2.2 Current address read

For the current address read operation, following a start condition, the bus master only sends a device select code with the R/W bit set to 1. The device acknowledges this, and outputs the byte addressed by the internal address counter. The counter is then incremented. The bus master terminates the transfer with a stop condition, as shown in Figure 11, without acknowledging the byte.

### 5.2.3 Sequential read

This operation can be used after a current address read or a random address read. The bus master does acknowledge the data byte output, and sends additional clock pulses so that the device continues to output the next byte in sequence. To terminate the stream of bytes, the bus master must not acknowledge the last byte, and must generate a Stop condition, as shown in Figure 11.

The output data comes from consecutive addresses, with the internal address counter automatically incremented after each byte output. After the last memory address, the address counter "rolls-over", and the device continues to output data from memory address 00h.

**Note:** *For device delivered in DFN5 package, after the last memory address (3FFh), the address counter doesn't roll-over to the memory address 00h. The next addresses and data bytes outputted are therefore undefined and not guarantee.*

The address counter contains meaningful address value only after a Random Address Read (with address value between 0 and 3FE) has been performed.

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## **6 Initial delivery state**

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The device is delivered with all the memory array bits set to 1 (each byte contains FFh).

## 7 Maximum rating

Stressing the device outside the ratings listed in Table 5 may cause permanent damage to the device. These are stress ratings only, and operation of the device at these, or any other conditions outside those indicated in the operating sections of this specification, is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Table 5. Absolute maximum ratings**

| Symbol            | Parameter                                             | Min.                    | Max. | Unit |
|-------------------|-------------------------------------------------------|-------------------------|------|------|
| -                 | Ambient operating temperature                         | -40                     | 130  | °C   |
| T <sub>STG</sub>  | Storage temperature                                   | -65                     | 150  | °C   |
| T <sub>LEAD</sub> | Lead temperature during soldering                     | see note <sup>(1)</sup> |      | °C   |
| I <sub>OL</sub>   | DC output current (SDA = 0)                           | -                       | 5    | mA   |
| V <sub>IO</sub>   | Input or output range                                 | -0.50                   | 6.5  | V    |
| V <sub>CC</sub>   | Supply voltage                                        | -0.50                   | 6.5  | V    |
| V <sub>ESD</sub>  | Electrostatic pulse (human body model) <sup>(2)</sup> | -                       | 3000 | V    |

1. Compliant with JEDEC Std J-STD-020 (for small body, Sn-Pb or Pb-free assembly), the ST ECOPACK 7191395 specification, and the European directive on Restrictions of Hazardous Substances (RoHS directive 2011/65/EU of July 2011).
2. Positive and negative pulses applied on different combinations of pin connections, according to ANSI/ESDA/JEDEC JS-001 (C1=100 pF, R1=1500 Ω).

## 8 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device.

**Table 6. Operating conditions (voltage range W)**

| Symbol   | Parameter                     | Min. | Max. | Unit |
|----------|-------------------------------|------|------|------|
| $V_{CC}$ | Supply voltage                | 2.5  | 5.5  | V    |
| $T_A$    | Ambient operating temperature | -40  | 85   | °C   |
| $f_C$    | Operating clock frequency     | -    | 400  | kHz  |

**Table 7. Operating conditions (voltage range R)**

| Symbol   | Parameter                     | Min. | Max. | Unit |
|----------|-------------------------------|------|------|------|
| $V_{CC}$ | Supply voltage                | 1.8  | 5.5  | V    |
| $T_A$    | Ambient operating temperature | -40  | 85   | °C   |
| $f_C$    | Operating clock frequency     | -    | 400  | kHz  |

**Table 8. Operating conditions (voltage range F)**

| Symbol   | Parameter                            | Min. |      |      | Max. | Unit |
|----------|--------------------------------------|------|------|------|------|------|
| $V_{CC}$ | Supply voltage                       | 1.60 | 1.65 | 1.70 | 5.5  | V    |
| $T_A$    | Ambient operating temperature: READ  | -40  | -40  | -40  | 85   | °C   |
|          | Ambient operating temperature: WRITE | 0    | -20  | -40  | 85   |      |
| $f_C$    | Operating clock frequency            | -    | -    | -    | 400  | kHz  |

**Table 9. AC measurement conditions**

| Symbol    | Parameter                                     | Min.                         | Max. | Unit |
|-----------|-----------------------------------------------|------------------------------|------|------|
| $C_{bus}$ | Load capacitance                              | 0                            | 100  | pF   |
| -         | SCL input rise/fall time, SDA input fall time | -                            | 50   | ns   |
| -         | Input levels                                  | 0.2 $V_{CC}$ to 0.8 $V_{CC}$ |      | V    |
| -         | Input and output timing reference levels      | 0.3 $V_{CC}$ to 0.7 $V_{CC}$ |      | V    |

**Figure 12. AC measurement I/O waveform**

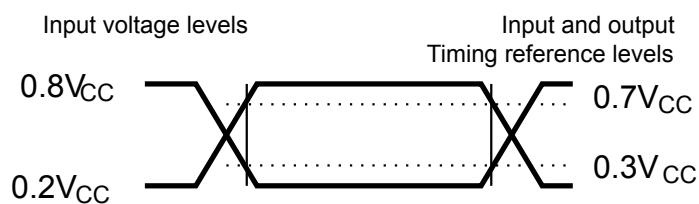


**Table 10. Input parameters**

| Symbol   | Parameter <sup>(1)</sup>            | Test condition        | Min. | Max. | Unit       |
|----------|-------------------------------------|-----------------------|------|------|------------|
| $C_{IN}$ | Input capacitance (SDA)             | -                     | -    | 8    | pF         |
| $C_{IN}$ | Input capacitance (other pins)      | -                     | -    | 6    | pF         |
| $Z_L$    | Input impedance ( $\overline{WC}$ ) | $V_{IN} < 0.3 V_{CC}$ | 15   | 70   | k $\Omega$ |
| $Z_H$    |                                     | $V_{IN} > 0.7 V_{CC}$ | 500  | -    | k $\Omega$ |

1. Evaluated by characterization – Not tested in production.

**Table 11. Cycling performance**

| Symbol | Parameter                            | Test condition                                                                             | Max.      | Unit        |
|--------|--------------------------------------|--------------------------------------------------------------------------------------------|-----------|-------------|
| Ncycle | Write cycle endurance <sup>(1)</sup> | $T_A \leq 25\text{ }^{\circ}\text{C}$ , $V_{CC}(\text{min}) < V_{CC} < V_{CC}(\text{max})$ | 4,000,000 | Write cycle |
|        |                                      | $T_A = 85\text{ }^{\circ}\text{C}$ , $V_{CC}(\text{min}) < V_{CC} < V_{CC}(\text{max})$    | 1,200,000 |             |

1. A write cycle is executed when either a page write or a byte write instruction is decoded.

**Table 12. Memory cell data retention**

| Parameter                     | Test condition                     | Min. | Unit |
|-------------------------------|------------------------------------|------|------|
| Data retention <sup>(1)</sup> | $T_A = 55\text{ }^{\circ}\text{C}$ | 200  | Year |

1. The data retention behaviour is checked in production, while the 200-year limit is defined from characterization and qualification results.

**Table 13. DC characteristics (M24C08-W)**

| Symbol          | Parameter                                                               | Test conditions (in addition to those in Table 6 and Table 9)                            | Min.         | Max.         | Unit    |
|-----------------|-------------------------------------------------------------------------|------------------------------------------------------------------------------------------|--------------|--------------|---------|
| $I_{LI}$        | Input leakage current<br>(E2, SCL, SDA)                                 | $V_{IN} = V_{SS}$ or $V_{CC}$ , device in standby mode                                   | -            | $\pm 2$      | $\mu A$ |
| $I_{LO}$        | Output leakage current                                                  | SDA in Hi-Z, external voltage applied on SDA: $V_{SS}$ or $V_{CC}$                       | -            | $\pm 2$      | $\mu A$ |
| $I_{CC}$        | Supply current (Read)                                                   | $f_C = 400$ kHz<br>$2.5 V \leq V_{CC} \leq 5.5 V$                                        | -            | 1            | mA      |
| $I_{CC0}^{(1)}$ | Supply current (Write)                                                  | Value averaged over $t_W$ ,<br>$2.5 V \leq V_{CC} \leq 5.5 V$                            | -            | 1            | mA      |
| $I_{CC1}$       | Standby supply current                                                  | Device not selected <sup>(2)</sup> ,<br>$V_{IN} = V_{SS}$ or $V_{CC}$ , $V_{CC} = 2.5 V$ | -            | 2            | $\mu A$ |
|                 |                                                                         | Device not selected <sup>(2)</sup> ,<br>$V_{IN} = V_{SS}$ or $V_{CC}$ , $V_{CC} = 5.5 V$ | -            | 3            | $\mu A$ |
| $V_{IL}$        | Input low voltage<br>(SCL, SDA, $\overline{WC}$ , E2)<br><sup>(3)</sup> | -                                                                                        | -0.45        | $0.3 V_{CC}$ | V       |
| $V_{IH}$        | Input high voltage<br>(SCL, SDA, $\overline{WC}$ , E2) <sup>(4)</sup>   | -                                                                                        | $0.7 V_{CC}$ | $V_{CC}+1$   | V       |
| $V_{OL}$        | Output low voltage                                                      | $I_{OL} = 2.1$ mA, $V_{CC} = 2.5 V$ or<br>$I_{OL} = 3$ mA, $V_{CC} = 5.5 V$              | -            | 0.4          | V       |

1. Evaluated by characterization - Not tested in production.

2. The device is not selected after power-up, after a read instruction (after the stop condition), or after the completion of the internal write cycle  $t_W$  ( $t_W$  is triggered by the correct decoding of a write instruction).

3. E2 input should be tied to  $V_{SS}$  (see Section 2.3 Chip enable (E2))

4. E2 input should be tied to  $V_{CC}$  (see Section 2.3 Chip enable (E2))

**Table 14. DC characteristics (M24C08-R)**

| Symbol          | Parameter                                                         | Test conditions <sup>(1)</sup> (in addition to those in Table 7 and Table 9)            | Min.          | Max.           | Unit    |
|-----------------|-------------------------------------------------------------------|-----------------------------------------------------------------------------------------|---------------|----------------|---------|
| $I_{LI}$        | Input leakage current (E2, SCL, SDA)                              | $V_{IN} = V_{SS}$ or $V_{CC}$ , device in standby mode                                  | -             | $\pm 2$        | $\mu A$ |
| $I_{LO}$        | Output leakage current                                            | SDA in Hi-Z, external voltage applied on SDA: $V_{SS}$ or $V_{CC}$                      | -             | $\pm 2$        | $\mu A$ |
| $I_{CC}$        | Supply current (Read)                                             | $V_{CC} = 1.8 V$ , $f_c = 400 kHz$                                                      | -             | 0.8            | mA      |
| $I_{CC0}^{(2)}$ | Supply current (Write)                                            | Value averaged over $t_W$<br>$V_{CC} \leq 2.5 V$                                        | -             | 1              | mA      |
| $I_{CC1}$       | Standby supply current                                            | Device not selected, <sup>(3)</sup><br>$V_{IN} = V_{SS}$ or $V_{CC}$ , $V_{CC} = 1.8 V$ | -             | 1              | $\mu A$ |
| $V_{IL}$        | Input low voltage (SCL, SDA, $\overline{WC}$ , E2) <sup>(4)</sup> | $2.5 V \leq V_{CC}$                                                                     | -0.45         | $0.3 V_{CC}$   | V       |
|                 |                                                                   | $V_{CC} < 2.5 V$                                                                        | -0.45         | $0.25 V_{CC}$  |         |
| $V_{IH}$        | Input high voltage (SCL, SDA)                                     | $V_{CC} < 2.5 V$                                                                        | $0.75 V_{CC}$ | 6.5            | V       |
|                 | Input high voltage ( $\overline{WC}$ , E2) <sup>(5)</sup>         | $V_{CC} < 2.5 V$                                                                        | $0.75 V_{CC}$ | $V_{CC} + 0.6$ | V       |
| $V_{OL}$        | Output low voltage                                                | $I_{OL} = 0.7 mA$ , $V_{CC} = 1.8 V$                                                    | -             | 0.2            | V       |

1. If the application uses the voltage range R device with  $2.5 V \leq V_{CC} \leq 5.5 V$  and  $-40^\circ C < T_A < +85^\circ C$ , refer to Table 13 instead of this table.
2. Evaluated by characterization - Not tested in production.
3. The device is not selected after power-up, after a read instruction (after the stop condition), or after the completion of the internal write cycle  $t_W$  ( $t_W$  is triggered by the correct decoding of a write instruction).
4. E2 input should be tied to  $V_{SS}$  (see Section 2.3 Chip enable (E2))
5. E2 input should be tied to  $V_{CC}$  (see Section 2.3 Chip enable (E2))

**Table 15. DC characteristics (M24C08-F)**

| Symbol          | Parameter                                                         | Test conditions <sup>(1)</sup> (in addition to those in Table 8 and Table 9)                | Min.          | Max.           | Unit    |
|-----------------|-------------------------------------------------------------------|---------------------------------------------------------------------------------------------|---------------|----------------|---------|
| $I_{LI}$        | Input leakage current (E2, SCL, SDA)                              | $V_{IN} = V_{SS}$ or $V_{CC}$<br>device in Standby mode                                     | -             | $\pm 2$        | $\mu A$ |
| $I_{LO}$        | Output leakage current                                            | SDA in Hi-Z, $V_{OUT} - V_{SS}$ or $V_{CC}$                                                 | -             | $\pm 2$        | $\mu A$ |
| $I_{CC}$        | Supply current (Read)                                             | $V_{CC} = 1.6 V$ or $1.7 V$ , $f_c = 400 kHz$                                               | -             | 0.8            | mA      |
| $I_{CC0}^{(2)}$ | Supply current (Write)                                            | Value averaged over $t_W$<br>$V_{CC} \leq 1.8 V$                                            | -             | 1              | mA      |
| $I_{CC1}$       | Standby supply current                                            | Device not selected <sup>(3)</sup> ,<br>$V_{IN} = V_{SS}$ or $V_{CC}$ , $V_{CC} \leq 1.8 V$ | -             | 1              | $\mu A$ |
| $V_{IL}$        | Input low voltage (SCL, SDA, $\overline{WC}$ , E2) <sup>(4)</sup> | $2.5 V \leq V_{CC}$                                                                         | -0.45         | $0.3 V_{CC}$   | V       |
|                 |                                                                   | $V_{CC} < 2.5 V$                                                                            | -0.45         | $0.25 V_{CC}$  |         |
| $V_{IH}$        | Input high voltage (SCL, SDA)                                     | $V_{CC} < 2.5 V$                                                                            | $0.75 V_{CC}$ | 6.5            | V       |
|                 | Input high voltage ( $\overline{WC}$ , E2) <sup>(5)</sup>         | $V_{CC} < 2.5 V$                                                                            | $0.75 V_{CC}$ | $V_{CC} + 0.6$ | V       |
| $V_{OL}$        | Output low voltage                                                | $I_{OL} = 0.7 mA$ , $V_{CC} = 1.8 V$                                                        | -             | 0.2            | V       |

1. If the application uses the voltage range F device with  $2.5 V \leq V_{CC} \leq 5.5 V$ , refer to Table 13 instead of this table.

2. Evaluated by characterization - Not tested in production.

3. The device is not selected after power-up, after a read instruction (after the stop condition), or after the completion of the internal write cycle  $t_W$  ( $t_W$  is triggered by the correct decoding of a write instruction).

4. E2 input should be tied to  $V_{SS}$  (see Section 2.3 Chip enable (E2))

5. E2 input should be tied to  $V_{CC}$  (see Section 2.3 Chip enable (E2))

**Table 16. 400 kHz AC characteristics (I<sup>2</sup>C Fast-mode)**

| Symbol             | Alt.         | Parameter                                                         | Min.              | Max. | Unit |
|--------------------|--------------|-------------------------------------------------------------------|-------------------|------|------|
| $f_C$              | $f_{SCL}$    | Clock frequency                                                   | -                 | 400  | kHz  |
| $t_{CHCL}$         | $t_{HIGH}$   | Clock pulse width high                                            | 600               | -    | ns   |
| $t_{CLCH}$         | $t_{LOW}$    | Clock pulse width low                                             | 1300              | -    | ns   |
| $t_{QL1QL2}^{(1)}$ | $t_F$        | SDA (out) fall time                                               | 20 <sup>(2)</sup> | 300  | ns   |
| $t_{XH1XH2}$       | $t_R$        | Input signal rise time                                            | (3)               | (3)  | ns   |
| $t_{XL1XL2}$       | $t_F$        | Input signal fall time                                            | (3)               | (3)  | ns   |
| $t_{DXCH}$         | $t_{SU:DAT}$ | Data in set up time                                               | 100               | -    | ns   |
| $t_{CLDX}$         | $t_{HD:DAT}$ | Data in hold time                                                 | 0                 | -    | ns   |
| $t_{CLQX}^{(4)}$   | $t_{DH}$     | Data out hold time                                                | 100               | -    | ns   |
| $t_{CLQV}^{(5)}$   | $t_{AA}$     | Clock low to next data valid (access time)                        | -                 | 900  | ns   |
| $t_{CHDL}^{(6)}$   | $t_{SU:STA}$ | Start condition setup time                                        | 600               | -    | ns   |
| $t_{DLCL}$         | $t_{HD:STA}$ | Start condition hold time                                         | 600               | -    | ns   |
| $t_{CHDH}$         | $t_{SU:STO}$ | Stop condition set up time                                        | 600               | -    | ns   |
| $t_{DHDL}$         | $t_{BUF}$    | Time between Stop condition and next Start condition              | 1300              | -    | ns   |
| $t_W$              | $t_{WR}$     | Write time                                                        | -                 | 5    | ms   |
| $t_{NS}^{(1)}$     | -            | Pulse width ignored (input filter on SCL and SDA) - single glitch | -                 | 100  | ns   |

1. Evaluated by characterization - Not tested in production.

2. With  $C_L = 10$  pF.

3. There is no min. or max. values for the input signal rise and fall times. It is however recommended by the I<sup>2</sup>C specification that the input signal rise and fall times be more than 20 ns and less than 300 ns when  $f_C < 400$  kHz.

4. The min value for  $t_{CLQX}$  (data out hold time) of the M24xxx devices offers a safe timing to bridge the undefined region of the falling edge SCL.

5.  $t_{CLQV}$  is the time (from the falling edge of SCL) required by the SDA bus line to reach either 0.3  $V_{CC}$  or 0.7  $V_{CC}$ , assuming that  $R_{bus} \times C_{bus}$  time constant is within the values specified in Figure 13.

6. For a restart condition, or following a write cycle.

**Table 17. 100 kHz AC characteristics (I<sup>2</sup>C standard-mode)**

| Symbol                             | Alt.                | Parameter                                                        | Min. | Max. | Unit |
|------------------------------------|---------------------|------------------------------------------------------------------|------|------|------|
| f <sub>C</sub>                     | f <sub>SCL</sub>    | Clock frequency                                                  | -    | 100  | kHz  |
| t <sub>CHCL</sub>                  | t <sub>HIGH</sub>   | Clock pulse width high                                           | 4    | -    | μs   |
| t <sub>CLCH</sub>                  | t <sub>LOW</sub>    | Clock pulse width low                                            | 4.7  | -    | μs   |
| t <sub>XH1XH2</sub>                | t <sub>R</sub>      | Input signal rise time                                           | -    | 1    | μs   |
| t <sub>XL1XL2</sub>                | t <sub>F</sub>      | Input signal fall time                                           | -    | 300  | ns   |
| t <sub>QL1QL2</sub> <sup>(1)</sup> | t <sub>F</sub>      | SDA (out) fall time                                              | -    | 300  | ns   |
| t <sub>DXCH</sub>                  | t <sub>SU:DAT</sub> | Data in setup time                                               | 250  | -    | ns   |
| t <sub>CLDX</sub>                  | t <sub>HD:DAT</sub> | Data in hold time                                                | 0    | -    | ns   |
| t <sub>CLQX</sub> <sup>(2)</sup>   | t <sub>DH</sub>     | Data out hold time                                               | 200  | -    | ns   |
| t <sub>CLQV</sub> <sup>(3)</sup>   | t <sub>AA</sub>     | Clock low to next data valid (access time)                       | -    | 3450 | ns   |
| t <sub>CHDL</sub> <sup>(4)</sup>   | t <sub>SU:STA</sub> | Start condition setup time                                       | 4.7  | -    | μs   |
| t <sub>DLCL</sub>                  | t <sub>HD:STA</sub> | Start condition hold time                                        | 4    | -    | μs   |
| t <sub>CHDH</sub>                  | t <sub>SU:STO</sub> | Stop condition setup time                                        | 4    | -    | μs   |
| t <sub>DHDL</sub>                  | t <sub>BUF</sub>    | Time between Stop condition and next Start condition             | 4.7  | -    | μs   |
| t <sub>W</sub>                     | t <sub>WR</sub>     | Write time                                                       | -    | 5    | ms   |
| t <sub>NS</sub> <sup>(1)</sup>     | -                   | Pulse width ignored (input filter on SCL and SDA), single glitch | -    | 100  | ns   |

1. Evaluated by characterization - Not tested in production.
2. To avoid spurious start and stop conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
3. t<sub>CLQV</sub> is the time (from the falling edge of SCL) required by the SDA bus line to reach either 0.3 V<sub>CC</sub> or 0.7 V<sub>CC</sub>, assuming that the R<sub>bus</sub> × C<sub>bus</sub> time constant is within the values specified in Figure 13.
4. For a reStart condition, or following a write cycle.

**Figure 13. Maximum  $R_{bus}$  value versus bus parasitic capacitance ( $C_{bus}$ ) for an I<sup>2</sup>C bus at maximum frequency  $f_C = 400$  kHz**

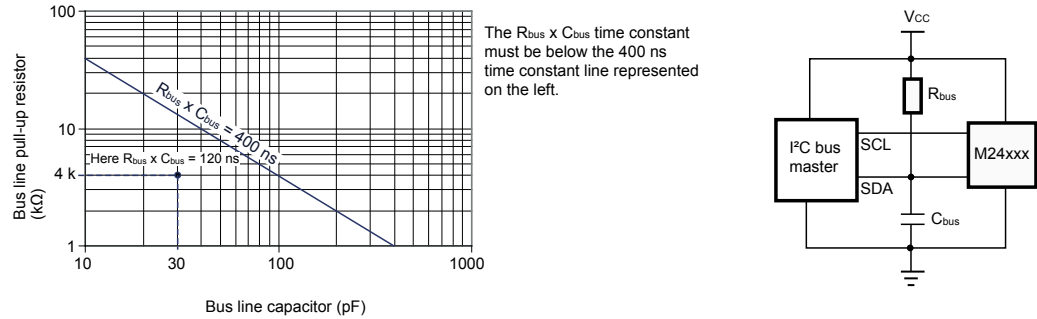
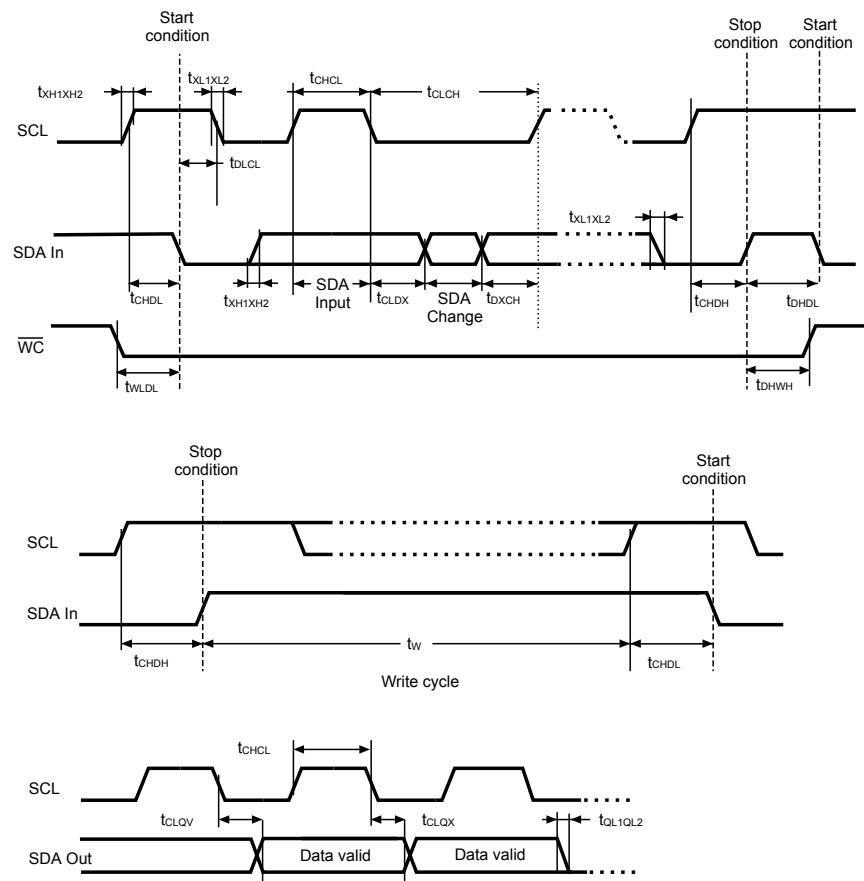


**Figure 14. AC waveforms**



## 9 Package information

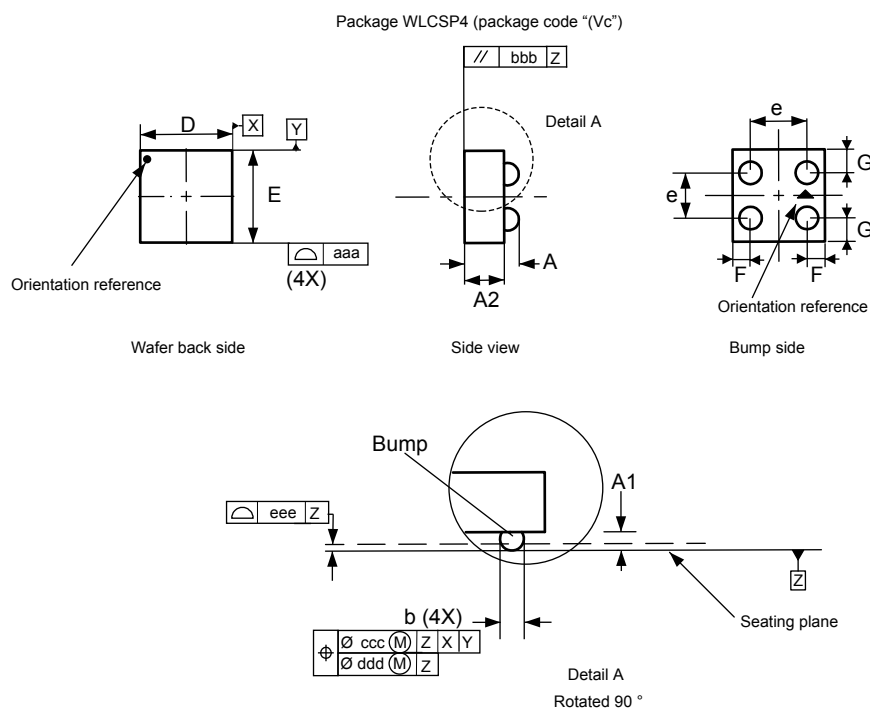
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).

ECOPACK is an ST trademark.

### 9.1 WLCSP4 package information

This WLCSP4 is a 4 ball, 0.703 x 0.713 mm, 0.4 mm pitch, wafer level chip scale package.

**Figure 15. WLCSP4 - Outline**



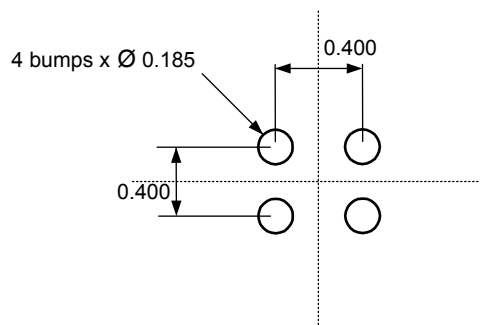
1. Drawing is not to scale.
2. Dimension is measured at the maximum bump diameter parallel to primary datum Z.
3. Primary datum Z and seating plane are defined by the spherical crowns of the bump.
4. Bump position designation per JESD 95-1, SPP-010.

**Table 18. WLCSP4 - Mechanical data**

| Symbol | Millimeters |       |       | Inches |        |        |
|--------|-------------|-------|-------|--------|--------|--------|
|        | Min         | Typ   | Max   | Min    | Typ    | Max    |
| A      | 0.270       | 0.295 | 0.330 | 0.0106 | 0.0116 | 0.0130 |
| A1     | -           | 0.095 | -     | -      | 0.0037 | -      |
| A2     | -           | 0.200 | -     | -      | 0.0079 | -      |
| b      | -           | 0.185 | -     | -      | 0.0073 | -      |
| D      | -           | 0.703 | 0.723 | -      | 0.0277 | 0.0285 |
| E      | -           | 0.713 | 0.733 | -      | 0.0281 | 0.0288 |
| e      | -           | 0.400 | -     | -      | 0.0157 | -      |
| F      | -           | 0.152 | -     | -      | 0.0060 | -      |
| G      | -           | 0.156 | -     | -      | 0.0061 | -      |
| aaa    | -           | 0.110 | -     | -      | 0.0043 | -      |
| bbb    | -           | 0.110 | -     | -      | 0.0043 | -      |
| ccc    | -           | 0.110 | -     | -      | 0.0043 | -      |
| ddd    | -           | 0.060 | -     | -      | 0.0024 | -      |
| eee    | -           | 0.060 | -     | -      | 0.0024 | -      |

1. Values in inches are converted from mm and rounded to 4 decimal digits.

### 9.1.1 WLCSP4 recommended footprint

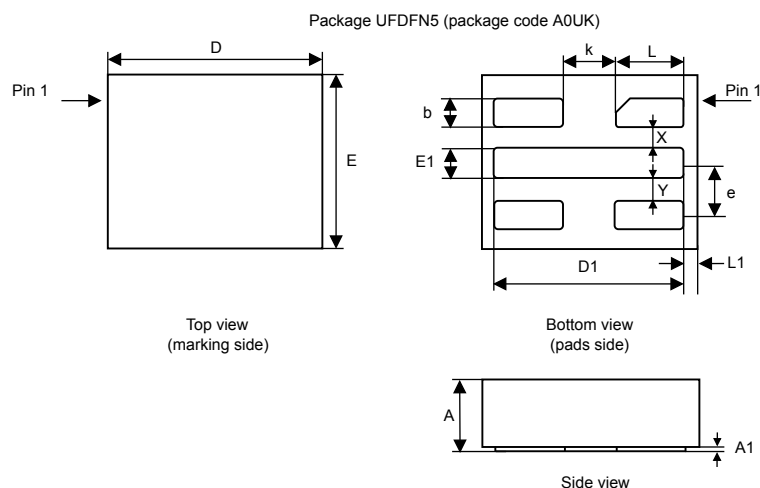
**Figure 16. WLCSP4 – Recommended footprint**


1. Dimensions are expressed in millimeters.

## 9.2 UFDFPN5 (DFN5) package information

UFDFPN5 is a 5-lead,  $1.7 \times 1.4$  mm, 0.55 mm thickness, ultra thin fine pitch dual flat package.

**Figure 17. UFDFPN5 - Outline**



1. Maximum package warpage is 0.05 mm.
2. Exposed copper is not systematic and can appear partially or totally according to the cross section.
3. Drawing is not to scale.
4. On the bottom side, pin 1 is identified by the specific pad shape and, on the top side, pin 1 is defined from the orientation of the marking. When reading the marking, pin 1 is below the upper left package corner.

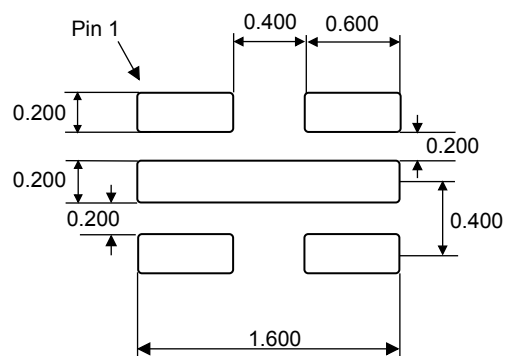
**Table 19. UFDFPN5 - Mechanical data**

| Symbol           | millimeters |       |       | inches |        |        |
|------------------|-------------|-------|-------|--------|--------|--------|
|                  | Min         | Typ   | Max   | Min    | Typ    | Max    |
| A                | 0.500       | 0.550 | 0.600 | 0.0197 | 0.0217 | 0.0236 |
| A1               | 0.000       | -     | 0.050 | 0.0000 | -      | 0.0020 |
| b <sup>(1)</sup> | 0.175       | 0.200 | 0.225 | 0.0069 | 0.0079 | 0.0089 |
| D                | 1.600       | 1.700 | 1.800 | 0.0630 | 0.0669 | 0.0709 |
| D1               | 1.400       | 1.500 | 1.600 | 0.0551 | 0.0591 | 0.0630 |
| E                | 1.300       | 1.400 | 1.500 | 0.0512 | 0.0551 | 0.0591 |
| E1               | 0.175       | 0.200 | 0.225 | 0.0069 | 0.0079 | 0.0089 |
| X                | -           | 0.200 | -     | -      | 0.0079 | -      |
| Y                | -           | 0.200 | -     | -      | 0.0079 | -      |
| e                | -           | 0.400 | -     | -      | 0.0157 | -      |
| L                | 0.500       | 0.550 | 0.600 | 0.0197 | 0.0217 | 0.0236 |
| L1               | -           | 0.100 | -     | -      | 0.0039 | -      |
| k                | -           | 0.400 | -     | -      | 0.0157 | -      |

1. Dimension b applies to plated terminal and is measured between 0.15 and 0.30mm from the terminal tip.

## 9.2.1 UFDFPN5 recommended footprint

**Figure 18. UFDFPN5 - Recommended footprint**

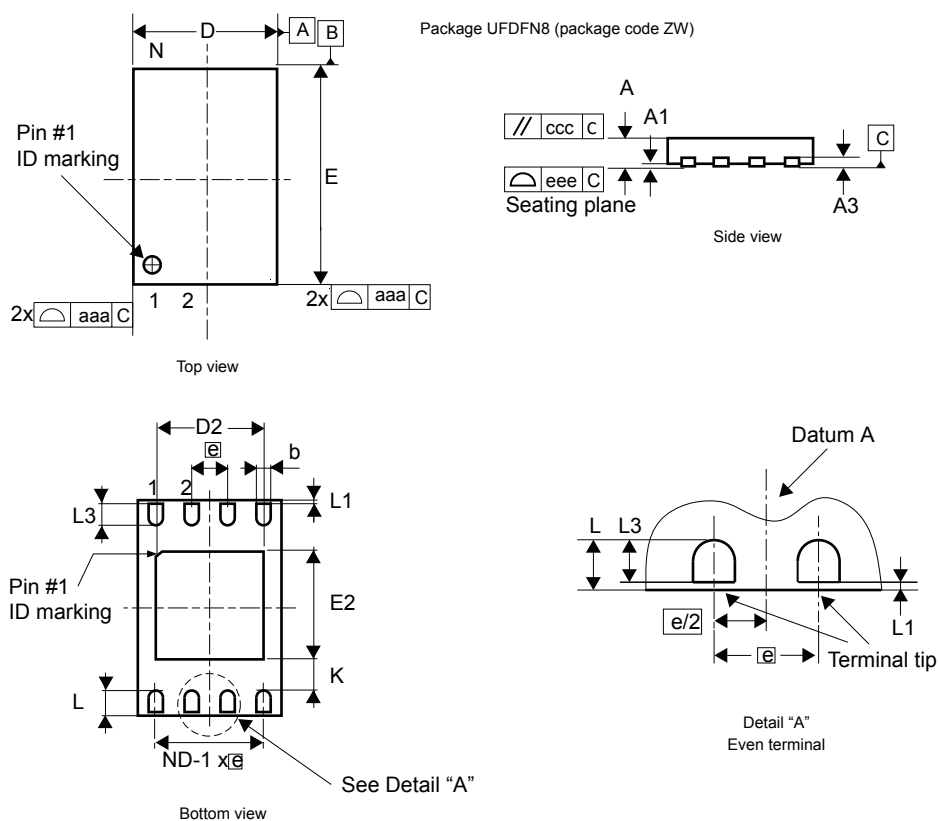


1. Dimensions are expressed in millimeters.

### 9.3 UFDFPN8 (DFN8) package information

This UFDFPN is a 8-lead, 2 x 3 mm, 0.5 mm pitch ultra thin profile fine pitch dual flat package.

**Figure 19. UFDFPN8 - Outline**



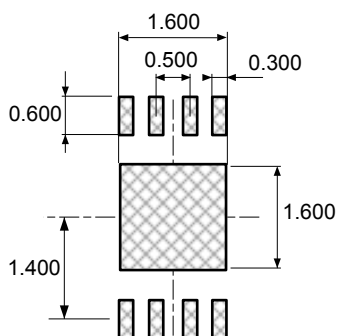
1. Maximum package warpage is 0.05 mm.
2. Exposed copper is not systematic and can appear partially or totally according to the cross section.
3. Drawing is not to scale.
4. The central pad (the area E2 by D2 in the above illustration) must be either connected to  $V_{SS}$  or left floating (not connected) in the end application.

**Table 20. UFDFPN8 - Mechanical data**

| Symbol             | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------------------|-------------|-------|-------|-----------------------|--------|--------|
|                    | Min         | Typ   | Max   | Min                   | Typ    | Max    |
| A                  | 0.450       | 0.550 | 0.600 | 0.0177                | 0.0217 | 0.0236 |
| A1                 | 0.000       | 0.020 | 0.050 | 0.0000                | 0.0008 | 0.0020 |
| b <sup>(2)</sup>   | 0.200       | 0.250 | 0.300 | 0.0079                | 0.0098 | 0.0118 |
| D                  | 1.900       | 2.000 | 2.100 | 0.0748                | 0.0787 | 0.0827 |
| D2                 | 1.200       | -     | 1.600 | 0.0472                | -      | 0.0630 |
| E                  | 2.900       | 3.000 | 3.100 | 0.1142                | 0.1181 | 0.1220 |
| E2                 | 1.200       | -     | 1.600 | 0.0472                | -      | 0.0630 |
| e                  | -           | 0.500 | -     | -                     | 0.0197 | -      |
| K                  | 0.300       | -     | -     | 0.0118                | -      | -      |
| L                  | 0.300       | -     | 0.500 | 0.0118                | -      | 0.0197 |
| L1                 | -           | -     | 0.150 | -                     | -      | 0.0059 |
| L3                 | 0.300       | -     | -     | 0.0118                | -      | -      |
| aaa                | -           | -     | 0.150 | -                     | -      | 0.0059 |
| bbb                | -           | -     | 0.100 | -                     | -      | 0.0039 |
| ccc                | -           | -     | 0.100 | -                     | -      | 0.0039 |
| ddd                | -           | -     | 0.050 | -                     | -      | 0.0020 |
| eee <sup>(3)</sup> | -           | -     | 0.080 | -                     | -      | 0.0031 |

1. Values in inches are converted from mm and rounded to four decimal digits.
2. Dimension b applies to plated terminal and is measured between 0.15 and 0.30 mm from the terminal tip.
3. Applied for exposed die paddle and terminals. Exclude embedding part of exposed die paddle from measuring.

### 9.3.1 UFDFPN8 recommended footprint

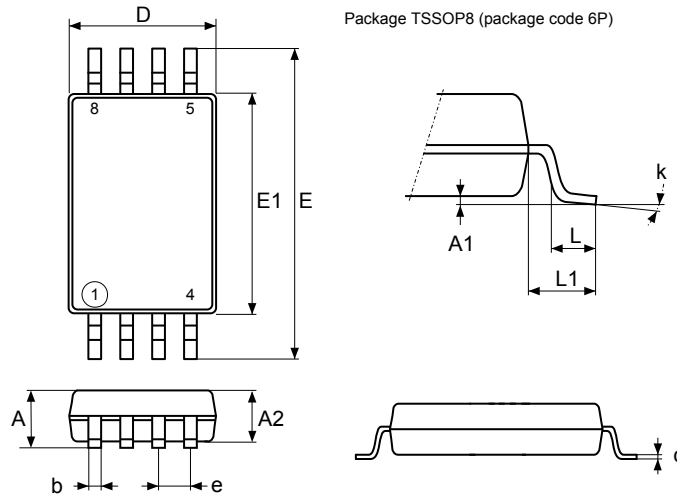
**Figure 20. UFDFPN8 - Recommended footprint**


1. Dimensions are expressed in millimeters.

## 9.4 TSSOP8 package information

This TSSOP is an 8-lead, 3 x 6.4 mm, 0.65 mm pitch, thin shrink small outline package.

**Figure 21. TSSOP8 – Outline**



1. Drawing is not to scale.

**Table 21. TSSOP8 – Mechanical data**

| Symbol            | millimeters |       |        | inches <sup>(1)</sup> |        |        |
|-------------------|-------------|-------|--------|-----------------------|--------|--------|
|                   | Min.        | Typ.  | Max.   | Min.                  | Typ.   | Max.   |
| A                 | -           | -     | 1.200  | -                     | -      | 0.0472 |
| A1                | 0.050       | -     | 0.150  | 0.0020                | -      | 0.0059 |
| A2                | 0.800       | 1.000 | 1.050  | 0.0315                | 0.0394 | 0.0413 |
| b                 | 0.190       | -     | 0.300  | 0.0075                | -      | 0.0118 |
| c                 | 0.090       | -     | 0.200  | 0.0035                | -      | 0.0079 |
| D <sup>(2)</sup>  | 2.900       | 3.000 | 3.100  | 0.1142                | 0.1181 | 0.1220 |
| e                 | -           | 0.650 | -      | -                     | 0.0256 | -      |
| E                 | 6.200       | 6.400 | 6.600  | 0.2441                | 0.2520 | 0.2598 |
| E1 <sup>(3)</sup> | 4.300       | 4.400 | 0.0177 | 0.1693                | 0.1732 | 0.1772 |
| L                 | 0.450       | 0.600 | 0.750  | 0.0181                | 0.0236 | 0.0295 |
| L1                | -           | 1.000 | -      | -                     | 0.0394 | -      |
| k                 | 0°          | -     | 8°     | 0°                    | -      | 8°     |
| aaa               | -           | -     | 0.100  | -                     | -      | 0.0039 |

1. Values in inches are converted from mm and rounded to four decimal digits.

2. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm per side.

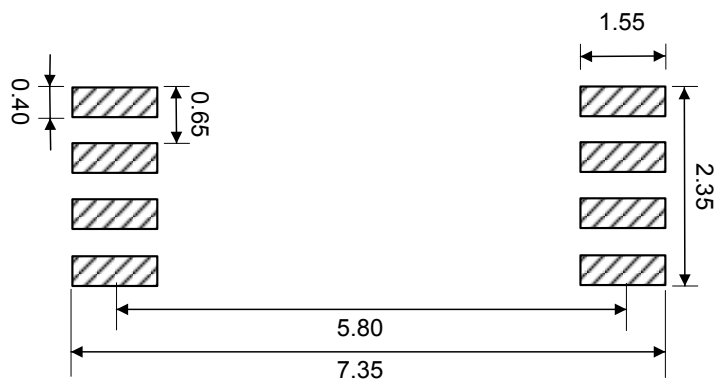
3. Dimension "E1" does not include interlead flash or protrusions. Interlead flash or protrusions shall not exceed 0.25 mm per side.

**Note:**

The package top may be smaller than the package bottom. Dimensions D and E1 are determined at the outermost extremes of the plastic body exclusive of mold flash, tie bar burrs, gate burrs and interleads flash, but including any mismatch between the top and bottom of plastic body. Measurement side for mold flash, protrusions or gate burrs is bottom side.

#### 9.4.1 TSSOP8 recommended footprint

Figure 22. TSSOP8 – Recommended footprint

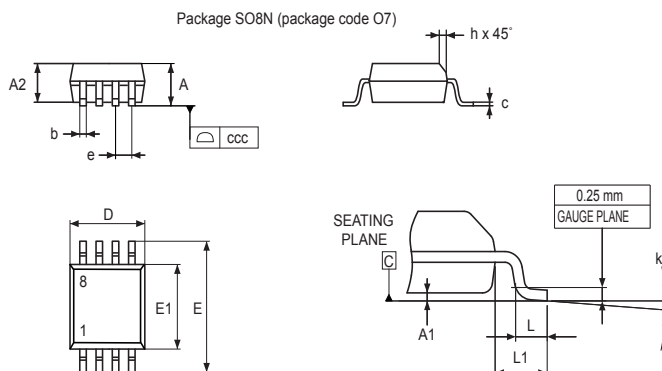


1. Dimensions are expressed in millimeters.

## 9.5 SO8N package information

This SO8N is an 8-lead, 4.9 x 6 mm, plastic small outline, 150 mils body width, package.

**Figure 23. SO8N – Outline**



1. Drawing is not to scale.

**Table 22. SO8N – Mechanical data**

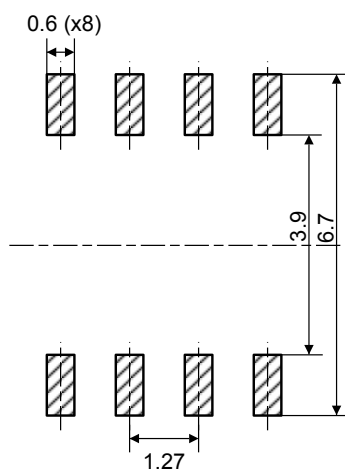
| Symbol            | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|-------------------|-------------|-------|-------|-----------------------|--------|--------|
|                   | Min.        | Typ.  | Max.  | Min.                  | Typ.   | Max.   |
| A                 | -           | -     | 1.750 | -                     | -      | 0.0689 |
| A1                | 0.100       | -     | 0.250 | 0.0039                | -      | 0.0098 |
| A2                | 1.250       | -     | -     | 0.0492                | -      | -      |
| b                 | 0.280       | -     | 0.480 | 0.0110                | -      | 0.0189 |
| c                 | 0.100       | -     | 0.230 | 0.0030                | -      | 0.0091 |
| D <sup>(2)</sup>  | 4.800       | 4.900 | 5.000 | 0.1890                | 0.1929 | 0.1969 |
| E                 | 5.800       | 6.000 | 6.200 | 0.2283                | 0.2362 | 0.2441 |
| E1 <sup>(3)</sup> | 3.800       | 3.900 | 4.000 | 0.1496                | 0.1535 | 0.1575 |
| e                 | -           | 1.270 | -     | -                     | 0.0500 | -      |
| h                 | 0.250       | -     | 0.500 | 0.0098                | -      | 0.0197 |
| k                 | 0°          | -     | 8°    | 0°                    | -      | 8°     |
| L                 | 0.400       | -     | 1.270 | 0.0157                | -      | 0.0500 |
| L1                | -           | 1.040 | -     | -                     | 0.0409 | -      |
| ccc               | -           | -     | 0.100 | -                     | -      | 0.0039 |

1. Values in inches are converted from mm and rounded to four decimal digits.
2. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm per side
3. Dimension "E1" does not include interlead flash or protrusions. Interlead flash or protrusions shall not exceed 0.25 mm per side.

**Note:** The package top may be smaller than the package bottom. Dimensions D and E1 are determined at the outermost extremes of the plastic body exclusive of mold flash, tie bar burrs, gate burrs and interleads flash, but including any mismatch between the top and bottom of plastic body. Measurement side for mold flash, protrusions or gate burrs is bottom side.

### 9.5.1 SO8N recommended footprint

Figure 24. SO8N - Recommended footprint



1. Dimensions are expressed in millimeters.

## 10 Ordering information

**Table 23. Ordering information scheme**

| Example:                                                                | M24 | C08 | -W | MC | 6 | T | P | /T |
|-------------------------------------------------------------------------|-----|-----|----|----|---|---|---|----|
| <b>Device type</b>                                                      |     |     |    |    |   |   |   |    |
| M24 = I <sup>2</sup> C serial access EEPROM                             |     |     |    |    |   |   |   |    |
| <b>Device function</b>                                                  |     |     |    |    |   |   |   |    |
| C08 = 8 Kbit (1K x 8 bit)                                               |     |     |    |    |   |   |   |    |
| <b>Operating voltage</b>                                                |     |     |    |    |   |   |   |    |
| W = V <sub>CC</sub> = 2.5 V to 5.5 V                                    |     |     |    |    |   |   |   |    |
| R = V <sub>CC</sub> = 1.8 V to 5.5 V                                    |     |     |    |    |   |   |   |    |
| F = V <sub>CC</sub> = 1.6 V or 1.7 V to 5.5 V                           |     |     |    |    |   |   |   |    |
| <b>Package<sup>(1)</sup></b>                                            |     |     |    |    |   |   |   |    |
| MN = SO8N (150 mil width)                                               |     |     |    |    |   |   |   |    |
| DW = TSSOP8 (169 mil width)                                             |     |     |    |    |   |   |   |    |
| MC = UFDFPN8 (DFN8)                                                     |     |     |    |    |   |   |   |    |
| MH = UFDFPN5 (DFN5)                                                     |     |     |    |    |   |   |   |    |
| CT = Thin WLCSP (chip scale package)                                    |     |     |    |    |   |   |   |    |
| <b>Device grade</b>                                                     |     |     |    |    |   |   |   |    |
| 6 = Industrial: device tested with standard test flow over -40 to 85 °C |     |     |    |    |   |   |   |    |
| <b>Option</b>                                                           |     |     |    |    |   |   |   |    |
| T = Tape and reel packing                                               |     |     |    |    |   |   |   |    |
| blank = tube packing                                                    |     |     |    |    |   |   |   |    |
| <b>Plating technology</b>                                               |     |     |    |    |   |   |   |    |
| P or G = RoHS compliant and halogen-free (ECOPACK2)                     |     |     |    |    |   |   |   |    |
| <b>Process</b>                                                          |     |     |    |    |   |   |   |    |
| /T = Manufacturing technology code <sup>(2)</sup>                       |     |     |    |    |   |   |   |    |

1. All packages are ECOPACK2 (RoHS-compliant and free of brominated, chlorinated and antimony-oxide flame retardants).
2. These process letters appear on the device package (marking) and on the shipment box. Please contact your nearest ST Sales Office for further information

**Note:** For a list of available options (memory, package, and so on) or for further information on any aspect of this device, contact your nearest ST sales office.

**Note:** Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering samples to run qualification activity.

## Revision history

**Table 24. Document revision history**

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|-------------|----------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 17-Dec-2012 | 1        | New single product M24C08 datasheet resulting from splitting the previous datasheet M24C08-x M24C04-x M24C02-x M24C01-x (revision 18) into separate datasheets.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| 25-Sep-2013 | 2        | <p>Added:</p> <ul style="list-style-type: none"> <li>Table 10: Cycling performance</li> <li>Table 6: Operating conditions (voltage range F, for devices identified by process letter T) and Table 7: Operating conditions (voltage range F, for all other devices).</li> </ul> <p>Updated:</p> <ul style="list-style-type: none"> <li>Features: supply voltage, write cycles and data retention</li> <li>Figure 49: AC waveforms</li> <li>Table 3: Absolute maximum ratings, Table 12: Memory cell data retention, Table 12: DC characteristics (M24128-W, device grade 6), Table 13: DC characteristics (M24128-R device grade 6), Table 14: DC characteristics (M24C32-F device), Table 84: Ordering information scheme</li> <li>Section 1: Description</li> </ul> <p>Renamed Figure 52 and Table 59.</p> <p>Replaced "5 bump" by "M24C08-FCT5TP/S" in WLCSP package description.</p> |
| 17-Dec-2016 | 3        | <p>Added Figure 4: This input signal is used to set the value that is to be looked for on the bit b3 of the device select code. This input must be tied to VCC or VSS, to establish the device select code as shown in Figure 4. When not connected (left floating), this input is read as low (0Chip enable inputs connection</p> <p>Updated:</p> <ul style="list-style-type: none"> <li>Table 12: DC characteristics (M24128-W, device grade 6), Table 13: DC characteristics (M24128-R device grade 6), Table 14: DC characteristics (M24C32-F device), Table 84: Ordering information scheme</li> <li>Figure 49: AC waveforms</li> </ul>                                                                                                                                                                                                                                            |
| 04-Jun-2014 | 4        | <p>Updated: Package on cover page</p> <p>Added note (1) on Table 1: Signal names.</p> <p>Updated note (1) and picture, deleted Caution note on Figure 3.</p> <p>Updated note (4) on Table 3.</p> <p>Corrected wrong Symbol name tDXCX in tDXCH in Table 15.</p> <p>Updated Figure 18: M24C08-FCT6TP/T package outline and Table 20: M24C08-FCT6TP/T package data.</p> <p>Added "Process" row specification in Table 84: Ordering information scheme.</p> <p>Added Figure 19</p>                                                                                                                                                                                                                                                                                                                                                                                                         |
| 04-May-2017 | 5        | <p>Added:</p> <ul style="list-style-type: none"> <li>UFDFPN5 in cover page and in Section 9: Package information, Figure 3: UFDFPN5 (DFN5) package connections, Engineering samples reference, Table 2: WLCSP signals vs. bump position</li> </ul> <p>Updated:</p> <ul style="list-style-type: none"> <li>Section 2.3: Chip Enable (E2), Section 4.5: Device addressing, Section 5.2.3: Sequential Read.</li> <li>note 1 on Table 1: Signal names,</li> <li>Table 3: Device select code, Table 25: Ordering information scheme.</li> </ul>                                                                                                                                                                                                                                                                                                                                              |
| 02-Oct-2017 | 6        | <p>Added reference to DFN8 and DFN5 in:</p> <p>Figure 3: UFDFPN5 (DFN5) package connections, Section 9.1: UFDFPN5 (DFN5) package information, Section 9.2: UFDFPN8 (DFN8) package information, Table 25: Ordering information scheme</p> <p>Updated Figure 11: Read mode sequence</p>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|-------------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 05-Jul-2022 | 7        | <p>Updated:</p> <ul style="list-style-type: none"> <li>Section Features, Section 1 Description, Section 2.2 Serial data (SDA), Section 3 Block diagram, Section 4.2 Stop condition, Section 4.5 Device addressing, WLCSP4 (CT) package information, Section 9.2 UFDFPN5 (DFN5) package information, Section 9.4 TSSOP8 package information, Section 9.5 SO8N package information, Section 9.3 UFDFPN8 (DFN8) package information, UFDFPN8 (DFN8) package information</li> <li>note in Figure 3, in Figure 4, in Figure 10, Table 10, in Table 12, in Table 16</li> <li>Table 5, Table 13, Table 14, Table 15, Table 23</li> </ul> <p>Removed Table 9. Operating conditions (voltage range F, for all other devices) and PDIP8 package</p> |

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